

# **IGBT Chip in NPT-technology**

### Features:

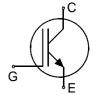
- 1200V NPT technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

### This chip is used for:

power module BSM 75GD120DN2

### **Applications:**

drives



Chip Type	<b>V</b> <sub>CE</sub>	<i>I</i> <sub>C</sub>	Die Size	Package
SIGC121T120R2C	1200V	75A	11.08 X 11.08 mm <sup>2</sup>	sawn on foil

#### **Mechanical Parameter**

Raster size	11.08 X 11.08			
Emitter pad size	8 x ( 2.99 x 1.97 )	mm²		
Gate pad size	1.46 x 0.8			
Area total	122.8			
Thickness	200	μm		
Wafer size	150	mm		
Max.possible chips per wafer	106			
Passivation frontside	Photoimide			
Pad metal	3200 nm AlSiCu			
Backside metal	Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	Electrically conductive glue or solder			
Wire bond	AI, <500μm			
Reject ink dot size	Ø 0.65mm ; max 1.2mm			
Recommended storage environment	Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C			



## **Maximum Ratings**

Parameter	Symbol	Value	Unit		
Collector-Emitter voltage, $T_{vj}$ =25 °C	V <sub>CE</sub>	1200	V		
DC collector current, limited by $T_{\rm vj\ max}$	I <sub>C</sub>	1)	А		
Pulsed collector current, $t_p$ limited by $T_{vj \text{ max}}$	$I_{c,puls}$	225	А		
Gate emitter voltage	$V_{GE}$	±20	V		
Junction temperature range	$T_{vj}$	-55 +175	°C		
Operating junction temperature	$T_{vj}$	-55+150	°C		
Short circuit data $^2$ ) $V_{GE} = 15V$ , $V_{CC} = 900V$ , $T_{vj} = 150$ $^{\circ}$ C	$t_{SC}$	10	μs		
Reverse bias safe operating area <sup>2)</sup> (RBSOA)	$I_{C,max} = 150A, V_{CE,max} = 1200V$ $T_{vj} \le 150^{\circ}C$				

<sup>1)</sup> depending on thermal properties of assembly

# **Static Characteristic** (tested on wafer), $T_{vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
Tarameter	Symbol		min.	typ.	max.	
Collector-Emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{\text{GE}}$ =0V , $I_{\text{C}}$ = 4mA	1200			
Collector-Emitter saturation voltage	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =75A	2.0	2.5	3.0	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =3mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			9.2	μA
Gate-Emitter leakage current	I <sub>GES</sub>	$V_{\text{CE}}$ =0V , $V_{\text{GE}}$ =20V			480	nA
Integrated gate resistor	$r_{\rm G}$			5		Ω

# Dynamic Characteristic (not subject to production test - verified by design / characterization),

*T*<sub>vi</sub> =25 °C

Parameter	Symbol	Conditions	Value			Unit
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Input capacitance	Cies	$V_{CE}=25V$ ,		5100		
Output capacitance	Coes	$V_{GE}=0V$ ,		720		pF
Reverse transfer capacitance	C <sub>res</sub>	f=1MHz		380		

<sup>&</sup>lt;sup>2)</sup> not subject to production test - verified by design/characterization

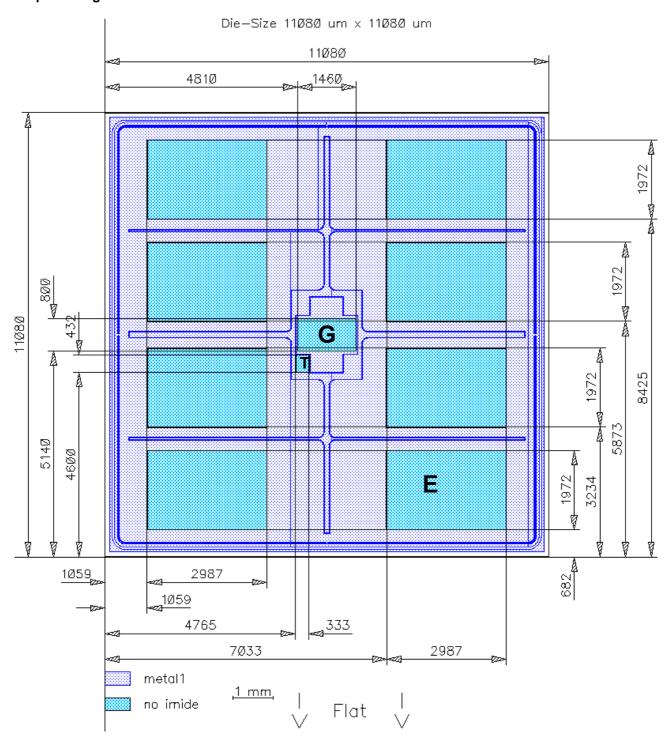


## **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



## **Chip Drawing**



E = Emitter pad

**G** = Gate pad

T = Test pad do not contact



#### Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

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